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MAR 2 4 2006

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March 24, 2006

VIA FACSIMILE (Total No. of Pages Transmitted: 4)

To: Primary Examiner Alexander O. Williams

Facsimile No.: 571-273-8300

Facsimile No.: 703-761-2375

Group Art Unit: 2826

U.S.P.T.O.

From: John J. Dresch, Esq. Facsimile

Re: Enclosed STATEMENT OF SUBSTANCE OF THE INTERVIEW

U.S. Patent Application No.: 10/695,453 Attorney Docket No.: T36-159874M/RS

Our Reference: NGB.322

Dear Examiner Williams:

Enclosed for filing is a Statement of the Substance of the Interview, which was conducted on March 21, 2006, in the above-referenced application, in compliance with M.P.E.P. § 713.04.

Applicant awaits the issuance of a new, non-final Office Action in this case. Thank you in advance for your kind consideration on this case.

Very truly yours,

John J. Dresch, Esq. Registration No. 46,672

JJD/SMM Enclosure

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MAR 2 4 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Ippei FUJIMOTO, et al.

Serial No.: 10/695,453

Group Art Unit:

2826

Filed:

October 29, 2003

Examiner:

Williams, Alexander O.

For: ELECTRODE FOR p-TYPE GROUP III NITRIDE COMPOUND

SEMICONDUCTOR AND METHOD FOR PRODUCING THE SAME

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

STATEMENT OF SUBSTANCE OF THE INTERVIEW

Sir:

Please review and enter the following remarks summarizing the telephonic interview conducted on March 21, 2006:

INTRODUCTORY COMMENTS

Remarks begin on page 2 of this paper.